

N-channel silicon field-effect transistors

Rev. 4 — 20 September 2011

Product data sheet

## 1. Product profile

### 1.1 General description

Symmetrical N-channel silicon junction field-effect transistors in a SOT23 package.

#### CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Therefore care should be taken during transport and handling.

### **1.2 Features and benefits**

- Low noise
- Interchangeability of drain and source connections
- High gain.

#### **1.3 Applications**

- AM input stage in car radios
- VHF amplifiers
- Oscillators and mixers.

### 1.4 Quick reference data

#### Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{\text{DS}}$	drain-source voltage		-	-	±25	V
V <sub>GSoff</sub>	gate-source cut-off voltage					
	PMBFJ308	$V_{DS}$ = 10 V; $I_D$ = 1 $\mu$ A	-1	-	-6.5	V
	PMBFJ309	$V_{DS}$ = 10 V; $I_D$ = 1 $\mu$ A	-1	-	-4	V
	PMBFJ310	$V_{DS}$ = 10 V; $I_D$ = 1 $\mu$ A	-2	-	-6.5	V



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Table 1.	Quick reference data col	ntinued				
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
I <sub>DSS</sub>	drain current					
	PMBFJ308	$V_{GS} = 0 V; V_{DS} = 10 V$	12	-	60	mA
	PMBFJ309	$V_{GS} = 0 V; V_{DS} = 10 V$	12	-	30	mA
	PMBFJ310	$V_{GS} = 0 V; V_{DS} = 10 V$	24	-	60	mA
P <sub>tot</sub>	total power dissipation	up to $T_{amb} = 25 \ ^{\circ}C$	-	-	250	mW
y <sub>fs</sub>	forward transfer admittance	$V_{DS} = 10 \text{ V}; \text{ I}_{D} = 10 \text{ mA}$	10	-	-	mS

### 2. Pinning information

Table 2.	Discrete pinning <sup>[1]</sup>		
Pin	Description	Simplified outline	Symbol
1	source		
2	drain		3 → 1
3	gate		sym060

[1] Drain and source are interchangeable.

### 3. Ordering information

Table 3. Ordering information						
Type number	Package	ckage				
	Name	Description	Version			
PMBFJ308	-	plastic surface mounted package; 3 leads	SOT23			
PMBFJ309						
PMBFJ310						

### 4. Marking

Table 4. Marking	
Type number	Marking code <sup>[1]</sup>
PMBFJ308	48*
PMBFJ309	49*
PMBFJ310	50*

[1] \* = p: Made in Hong Kong.

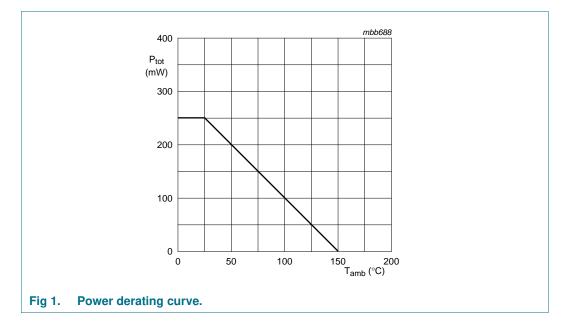
\* = t: Made in Malaysia.

\* = W: Made in China.

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### 5. Limiting values

Table 5. In accorda	Limiting values nce with the Absolute Maximum F	Rating System (IEC 60134).			
Symbol	Parameter	Conditions	Min	Мах	Unit
V <sub>DS</sub>	drain-source voltage (DC)		-	±25	V
V <sub>GSO</sub>	gate-source voltage	open drain	-	-25	V
$V_{GDO}$	gate-drain voltage	open source	-	-25	V
l <sub>G</sub>	forward gate current (DC)		-	50	mA
P <sub>tot</sub>	total power dissipation	up to T <sub>amb</sub> = 25 °C	-	250	mW
T <sub>stg</sub>	storage temperature		-65	+150	°C
Tj	junction temperature		-	150	°C



## 6. Thermal characteristics

Table 6.	Thermal characteristics			
Symbol	Parameter	Conditions	Тур	Unit
R <sub>th(j-a)</sub>	thermal resistance from junction to ambient		<u>[1]</u> 500	K/W

[1] Device mounted on an FR4 printed-circuit board.

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## 7. Static characteristics

#### Table 7.Static characteristics

 $T_i = 25 \ ^{\circ}C$ ; unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V <sub>(BR)GSS</sub>	gate-source breakdown voltage	$I_G = -1 \ \mu A; \ V_{DS} = 0 \ V$	-25	-	-	V
V <sub>GSoff</sub>	gate-source cut-off voltage					V
	PMBFJ308	$I_D = 1 \ \mu A; \ V_{DS} = 10 \ V$	–1	-	-6.5	V
	PMBFJ309	$I_D = 1 \ \mu A; \ V_{DS} = 10 \ V$	–1	-	-4	V
	PMBFJ310	$I_D=1~\mu A;~V_{DS}=10~V$	-2	-	-6.5	V
V <sub>GSS</sub>	gate-source forward voltage	$I_{G} = 1 \text{ mA}; V_{DS} = 0 \text{ V}$	-	-	1	V
I <sub>DSS</sub>	drain-source leakage current					
	PMBFJ308	$V_{GS} = 0 V; V_{DS} = 10 V$	12	-	60	mA
	PMBFJ309	$V_{GS} = 0 V; V_{DS} = 10 V$	12	-	30	mA
	PMBFJ310	$V_{GS} = 0 V; V_{DS} = 10 V$	24	-	60	mA
I <sub>GSS</sub>	gate-source leakage current	$V_{GS} = -15 \text{ V};  V_{DS} = 0 \text{ V}$	-	-	-1	nA
R <sub>DSon</sub>	drain-source on-state resistance	$V_{GS} = 0 V; V_{DS} = 100 mV$	-	50	-	Ω
y <sub>fs</sub>	forward transfer admittance	$I_D = 10 \text{ mA}; V_{DS} = 10 \text{ V}$	10	-	-	mS
y <sub>os</sub>	common source output admittance	I <sub>D</sub> = 10 mA; V <sub>DS</sub> = 10 V	-	-	250	μS

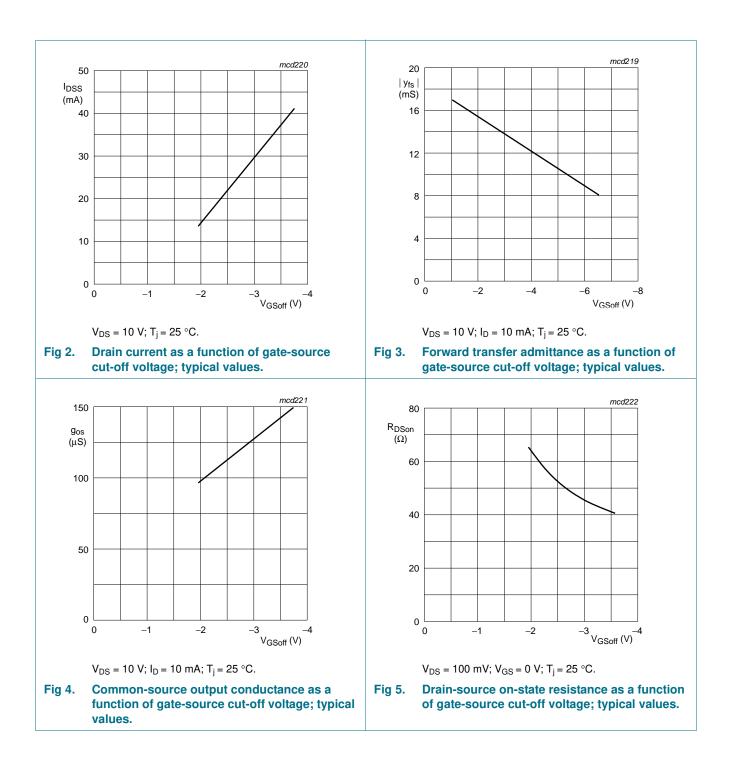
### 8. Dynamic characteristics

#### Table 8.Dynamic characteristics

$T_i = 25 \ ^{\circ}C$ ; unless otherwise specified
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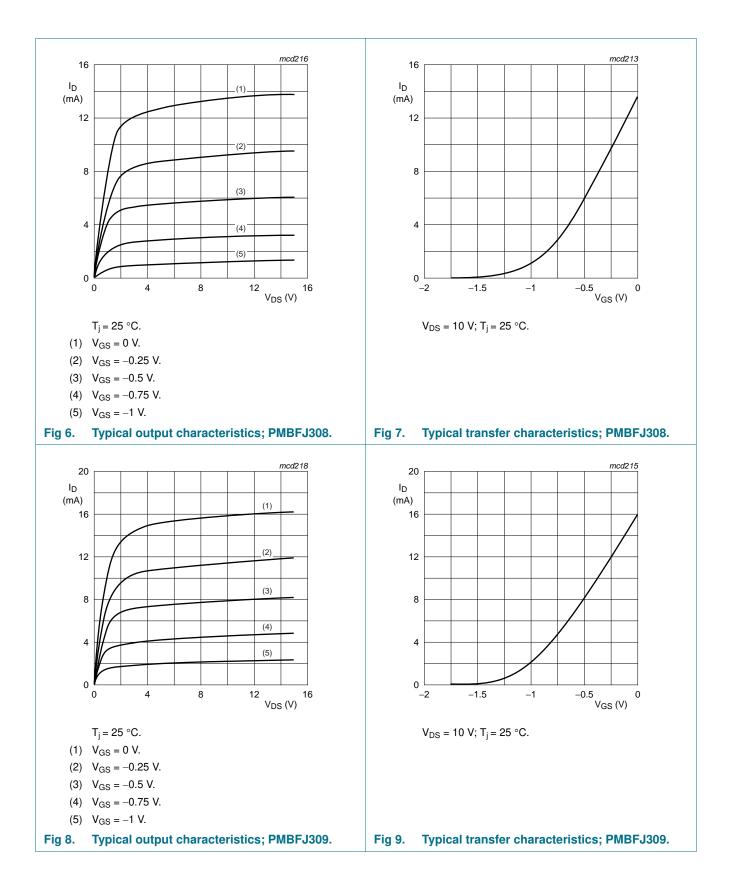
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
C <sub>iss</sub>	input capacitance	V <sub>DS</sub> = 10 V				
		$V_{GS} = -10 \text{ V}; \text{ f} = 1 \text{ MHz}$	-	3	5	рF
		$V_{GS}$ = 0 V; $T_{amb}$ = 25 °C	-	6	-	рF
C <sub>rss</sub>	reverse transfer capacitance	$V_{DS}$ = 0 V; $V_{GS}$ = -10 V; f = 1 MHz	-	1.3	2.5	pF
g <sub>is</sub>	input conductance	$V_{DS} = 10 \text{ V}; I_{D} = 10 \text{ mA}$				
		f = 100 MHz	-	200	-	μS
		f = 450 MHz	-	3	-	mS
g <sub>fs</sub>	transfer conductance	$V_{DS} = 10 \text{ V}; I_{D} = 10 \text{ mA}$				
		f = 100 MHz	-	13	-	mS
		f = 450 MHz	-	12	-	mS
g <sub>rs</sub> reverse conductance		$V_{DS} = 10 \text{ V}; I_D = 10 \text{ mA}$				
		f = 100 MHz	-	-30	-	μS
		f = 450 MHz	-	-450	-	μS
g <sub>os</sub>	output conductance	$V_{DS} = 10 \text{ V}; I_D = 10 \text{ mA}$				
		f = 100 MHz	-	150	-	μS
		f = 450 MHz	-	400	-	μS
√ <sub>n</sub>	equivalent input noise voltage	$V_{DS} = 10 \text{ V}; I_D = 10 \text{ mA}; f = 100 \text{ Hz}$	-	6	-	nV/√⊢

## PMBFJ308; PMBFJ309; PMBFJ310



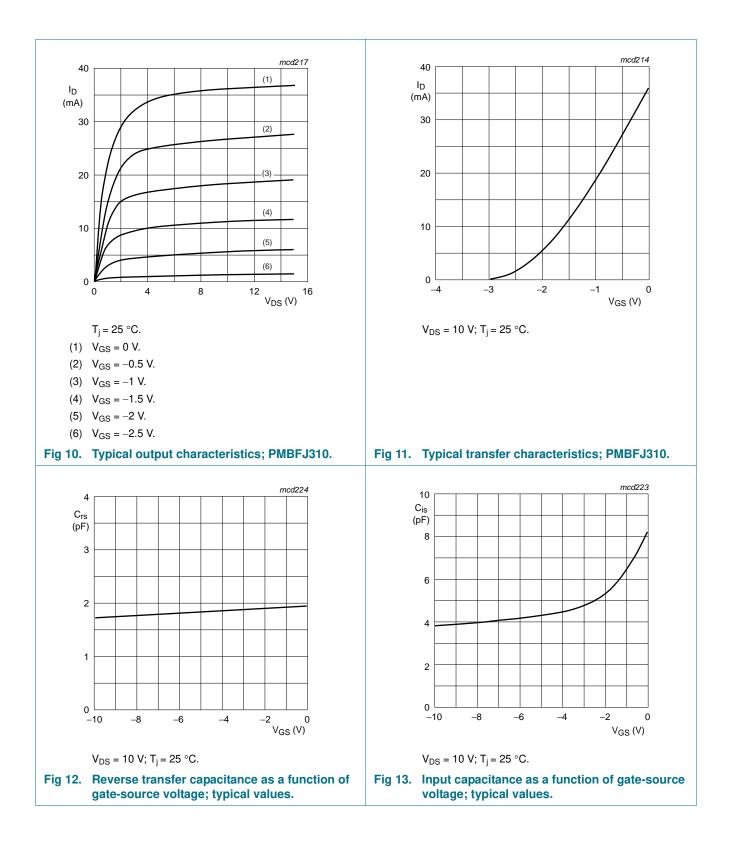
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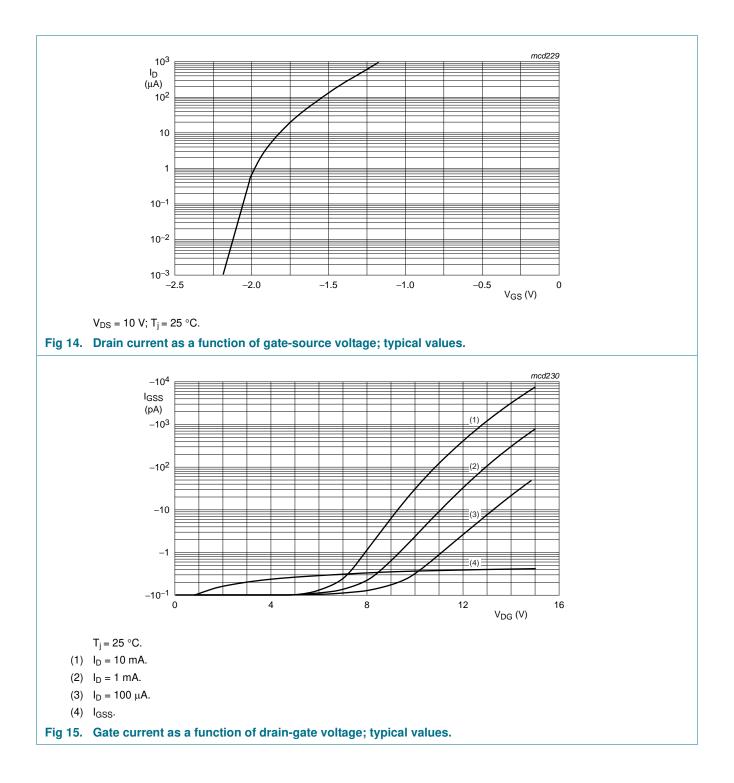
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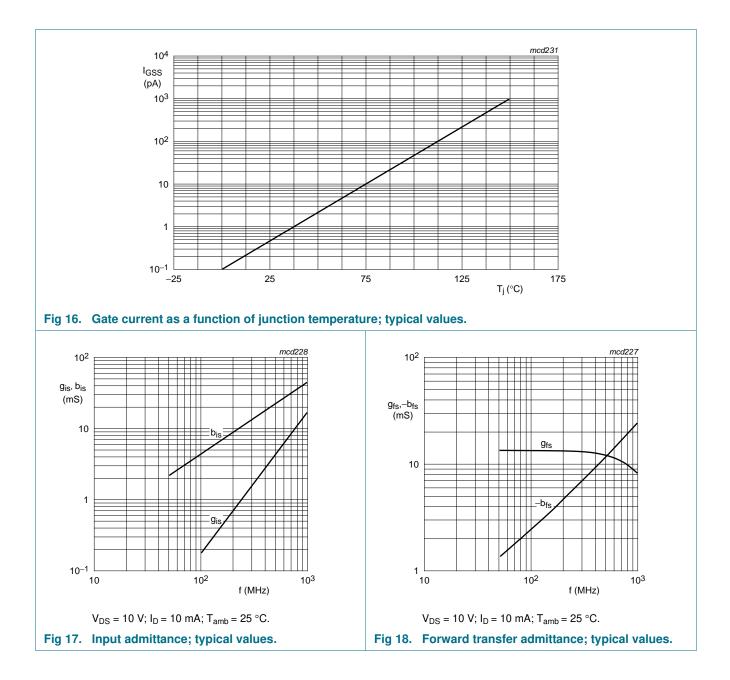


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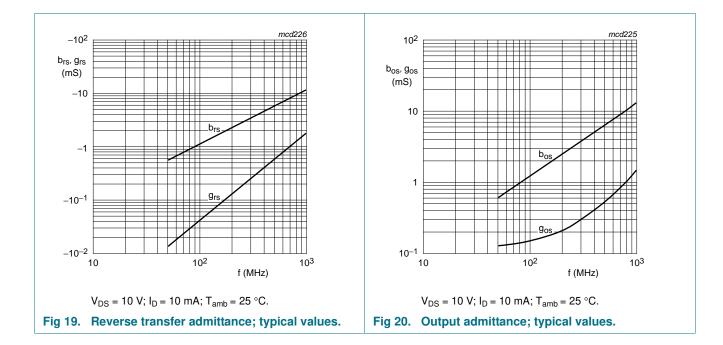






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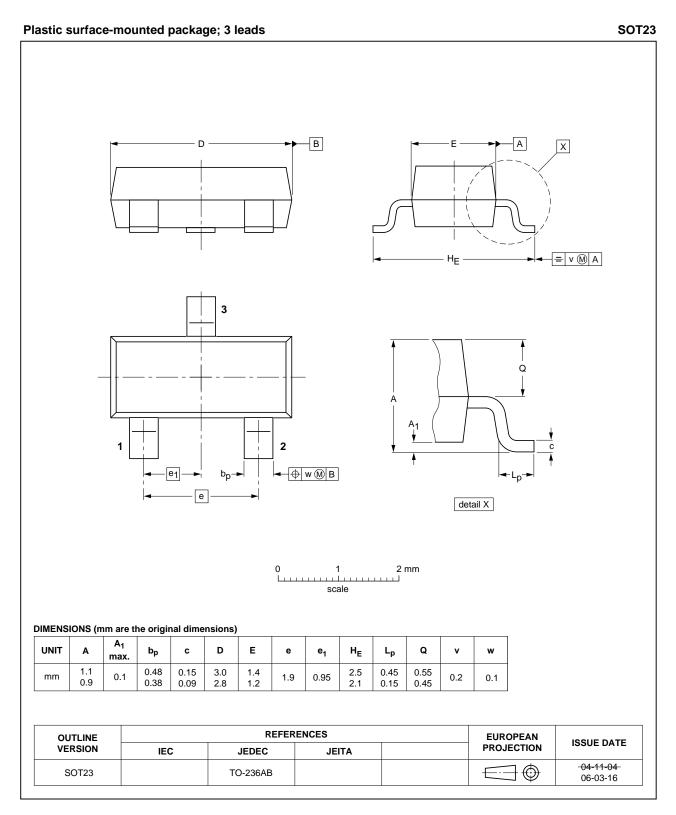
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### 9. Package outline



#### Fig 21. Package outline.

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## 10. Revision history

Revision history				
: ID	Release date	Data sheet status	Change notice	Supersedes
309_310 v.4	20110920	Product data sheet	-	PMBFJ308_309_310 v.3
ns:	guidelines c • Legal texts	of NXP Semiconductors. have been adapted to th	e new company n	ame where appropriate.
	20040723	Product data sheet	-	PMBFJ308_309_310 v.2
3_309_310 v.2 01141)	19960911	Product specification	-	-
	t ID 3_309_310 v.4 sns: 3_309_310 v.3 13403) 3_309_310 v.2	ID         Release date           3_309_310 v.4         20110920           ins:         • The formating uidelines of example.           • Legal texts         • Package ou           3_309_310 v.3         20040723           13403)         19960911	IDRelease dateData sheet status3_309_310 v.420110920Product data sheeta.so9_310 v.420110920Product data sheetins:• The format of this data sheet has be guidelines of NXP Semiconductors. • Legal texts have been adapted to th • Package outline drawings have been3_309_310 v.3 13403)20040723Product data sheet3_309_310 v.219960911Product specification	IDRelease dateData sheet statusChange notice3_309_310 v.420110920Product data sheet-ins:• The format of this data sheet has been redesigned to guidelines of NXP Semiconductors. • Legal texts have been adapted to the new company n • Package outline drawings have been updated to the la3_309_310 v.3 13403)20040723Product data sheet -3_309_310 v.219960911Product specification

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## 11. Legal information

#### 11.1 Data sheet status

Document status[1][2]	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
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